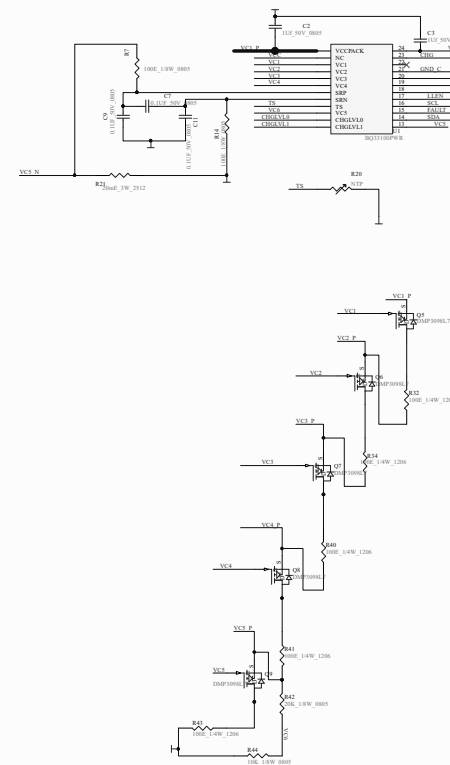
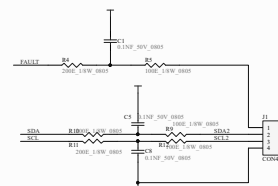
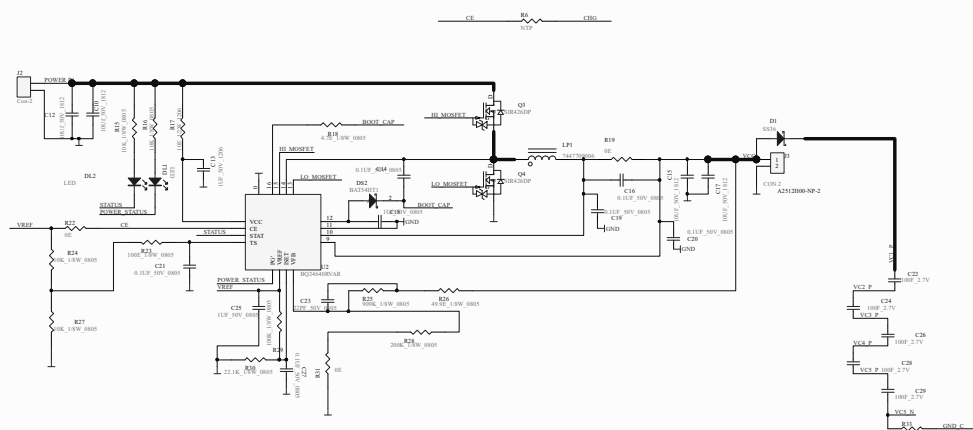
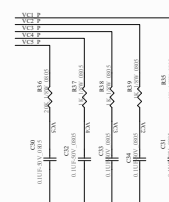
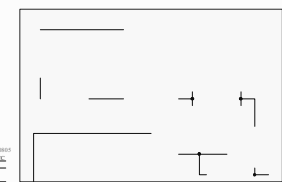




volatge level of Bq33100 CHG pin during LLEN enable & disble ?
this section burn out during ESR & capacitance measurement



Title		
Doc	Number	Revision
Doc	57-04-2014	1.000-01
Doc	57-04-2014	1.000-01